



THE DATASHEET OF SIGC42T60UNX1SA1



High Speed IGBT Chip in NPT-technology

FEATURES:

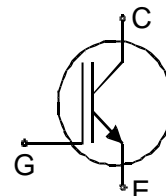
- low E_{off}
 - 600V NPT technology
 - 100µm chip
 - short circuit prove
 - positive temperature coefficient
- easy paralleling

This chip is used for:

- SGW50N60HS

Applications:

- Welding
- PFC
- UPS



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC42T60UN	600V	50A	6.5 x 6.5 mm ²	sawn on foil	SP0001-01820

MECHANICAL PARAMETER:

Raster size	6.5 x 6.5	mm ²
Area total / active	42.25 / 35.6	
Emitter pad size	2x(3.0x2.85)	
Gate pad size	0.8 x 1.5	
Thickness	100	µm
Wafer size	150	mm
Flat position	90	deg
Max.possible chips per wafer	334	
Passivation frontside	Photoimide	
Emitter metallization	3200 nm Al Si 1%	
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding	
Die bond	electrically conductive glue or solder	
Wire bond	Al, ≤500µm	
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm	
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C	



SIGC42T60UN

MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, $T_j=25\text{ °C}$	V_{CE}	600	V
DC collector current, limited by T_{jmax}	I_C	1)	A
Pulsed collector current, t_p limited by T_{jmax}	I_{Cpuls}	150	A
Gate emitter voltage	V_{GE}	± 20	V
Operating junction and storage temperature	T_j, T_{stg}	-55 ... +150	$^{\circ}\text{C}$

1) depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), $T_j=25\text{ °C}$, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}=0V, I_C=2mA$	600			V
Collector-emitter saturation voltage	$V_{CE(sat)}$	$V_{GE}=15V, I_C=50A$		2.8	3.15	
Gate-emitter threshold voltage	$V_{GE(th)}$	$I_C=1mA, V_{GE}=V_{CE}$	3	4	5	
Zero gate voltage collector current	I_{CES}	$V_{CE}=600V, V_{GE}=0V$			40	μA
Gate-emitter leakage current	I_{GES}	$V_{CE}=0V, V_{GE}=20V$			120	nA

DYNAMIC CHARACTERISTICS (tested at component):

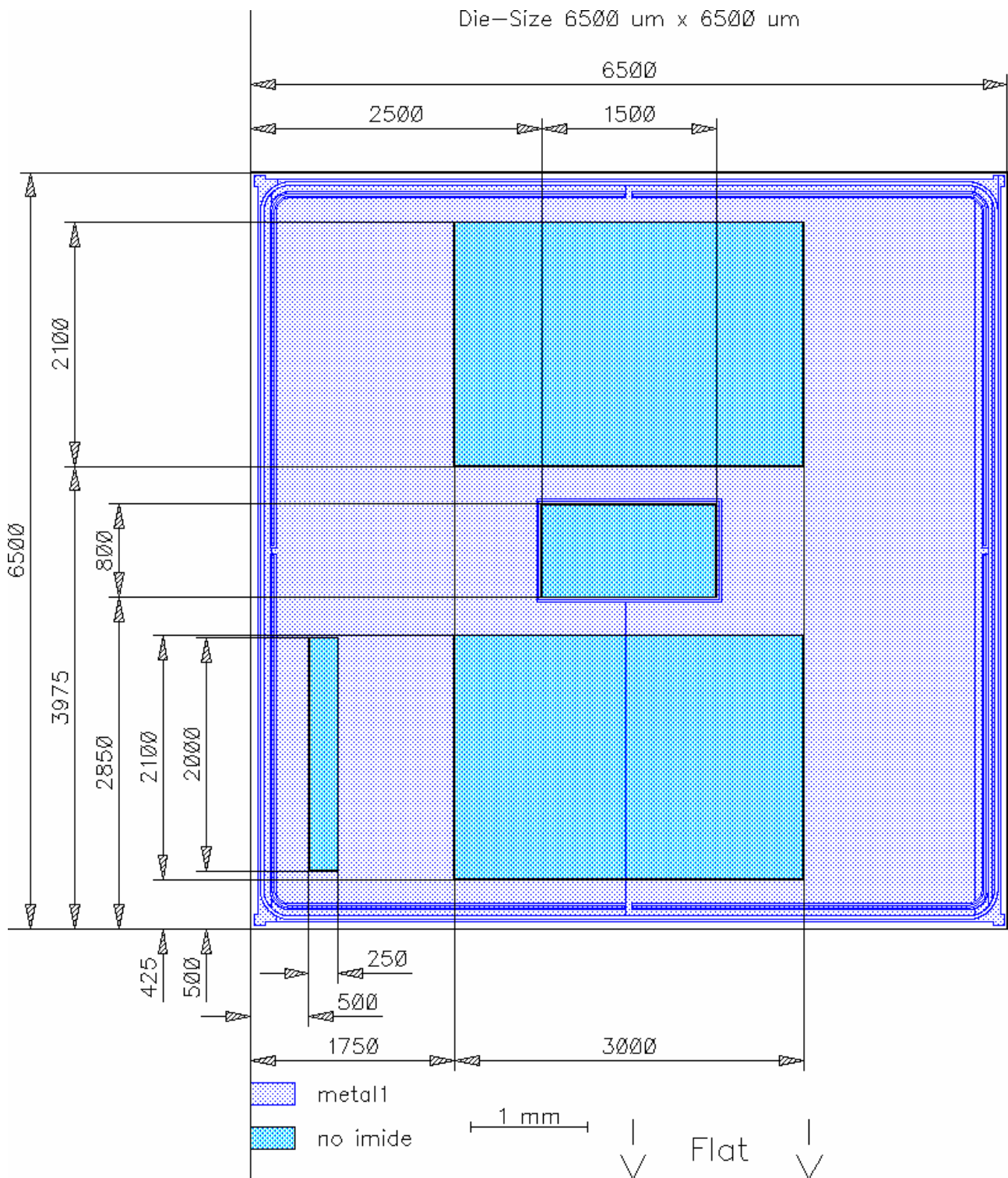
Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Input capacitance	C_{iss}	$V_{CE}=25V$	-	2572		pF
Output capacitance	C_{oss}	$V_{GE}=0V$	-	245		
Reverse transfer capacitance	C_{riss}	$f=1\text{MHz}$	-	158		

SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions*	Value			Unit
			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	$T_j=150\text{ °C}$ $V_{CC}=400V$	-	48		ns
Rise time	t_r	$I_C=50A$	-	31		
Turn-off delay time	$t_{d(off)}$	$V_{GE}=+15/0V$ $R_G=6.8\Omega$	-	350		
Fall time	t_f		-	20		

* Values also influenced by parasitic L- and C- in measurement and package.

CHIP DRAWING:





SIGC42T60UN

FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

SGW50N60HS

Package :TO247

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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